

Application/Control No.	Applicant(s)/Patent under Reexamination
10/801 9/0	BAEK ET AL

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2883

Examiner Art Unit

Brian M. Healy

SEARCHED Class Subclass Date Examiner 385 122 3/27/2006 BMH 123 14 129 130 131 65 385 438 29,31

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
SEARCH	3/27/2006	вмн		
NOTES				
	Subclass SEARCH	Subclass Date SEARCH 3/27/2006		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
SEARCHED "EAST" (SEARCH TERMS, CLASS/SUBCLASSES AND DATABASES RELIED UPON ARE LISTED ON PRINTOUT.)	3/27/2006	вмн	
EAST SEARCH PRINTOUT ALSO INCLUDES INTERFERENCE SEARCH TERMS.	3/27/2006	вмн	
PALM INVENTOR SEARCH	3/27/2006	вмн	
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